



Low Voltage SPDT Analog Switch 2:1 Mux/Demux Bus Switch

Features

- CMOS Technology for Bus and Analog Applications
- Low On-Resistance: 8Ω at 3.0V
- Wide VCC Range: 1.65V to 5.5V
- Rail-to-Rail Signal Range
- Control Input Overvoltage Tolerance: 5.5V
- Fast Transition Speed: 2ns at 5.0V
- High Off Isolation: -63dB @ 10MHz
- Break-Before-Make Switching
- High Bandwidth: 350MHz
- Extended Industrial Temperature Range: -40°C to 85°C
- PI5A3157B Is Improved Direct Replacement for NC7SB3157
- Packaging (Pb-free & Green):
 -6-pin UDFN 1mm×1mm
 - -6-pin SC70

Description

The PI5A3157B is a high-bandwidth, fast single-pole double-throw (SPDT) CMOS switch. It can be used as an analog switch or as a low-delay bus switch. Specified over a wide operating power supply voltage range, 1.65V to 5.5V, the PI5A3157B has a maximum ON resistance of 12-ohms at 1.65V, 9-ohms at 2.3V & 6-ohms at 4.5V.

Break-before-make switching prevents both switches being enabled simultaneously. This eliminates signal disruption during switching.

The control input, S, is independent of supply voltage. PI5A3157B is an improved direct replacement for the NC7SB3157.

Application

- Cell Phones
- PDAs
- MP3 Players
- Portable Instrumentation
- Battery powered Communications
- Computer Peripherals

Pin Assignment



Pin Description

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Pin No		Pin Name	Decomintion					
SC70-6	UDFN-6	rin name	Description					
1	2	B1	Data Port					
2	5	GND	Ground					
3	4	B0	Data Port (Normally connected)					
4	3	А	Common Output/Data Port					
5	1	V _{CC}	Positive Power Supply					
6	6	S	Logic control					

Logic Function Table

Logic Inputs(S)	Function
0	B ₀ connect to A
1	B ₁ connect to A





Maximum Ratings

Storage Temperature	65°C to +150°C
Ambient Temperature with Power Applied	40°C to +85°C
Supply Voltage V _{CC}	0.5V to +7.0V
DC Control Input Voltage V _S	0.5V to +7.0V
DC Input Voltage V _{IN}	0.5V to V_{CC} +0.5V
DC Output Current V _{OUT}	128mA
DC V _{CC} or Ground Current I _{CC} /I _{GND}	±100mA
Junction Temperature under Bias (TJ)	150°C
Junction Lead Temperature (TL)	
(Soldering, 10 seconds)	
Power Dissipation (PD) @ +85°C	180mW
ESD(HBM)	2000V

Note:

Stresses greater than those listed under MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

Recommended Operating Conditions

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
V _{CC}	Operating Voltage	-	1.65	-	5.5	V
Vs	Control Input Voltage	-	0	-	5.5	V
V _{IN}	Switch Input Voltage	-	0	-	V _{CC}	V
V _{OUT}	Output Voltage	-	0	-	V _{CC}	V
T _A	Operating Temperature	-	-40	25	85	°C
Ts						
ta tf	Input Diss and Fall Time	Control Input $V_{CC} = 2.3V$ to $3.6V$	0	-	10	ns/V
tr, tf	Input Rise and Fall Time	Control Input $VCC = 4.5V$ to $5.5V$	0	-	5	ns/V

Note: Control input must be held HIGH or LOW; it must not float.





Parameter	Description	Test Conditions	Temperature (T _A :℃)	Min.	Тур.	Max.	Unit
V _{IAR}	Analog Input Signal Range	V _{CC}	-40°C to 85°C	0	-	V _{CC}	v
		V_{CC} =4.5V, I_{O} = 30mA, V_{IN} = 0V		-	4	6	
		V_{CC} =4.5V, I_{O} =-30mA, V_{IN} =2.4V	25°C	-	5	8	
		V_{CC} =4.5V, I_{O} =-30mA, V_{IN} =4.5V		-	7	11	
		V_{CC} =4.5V, I_{O} =30mA, V_{IN} =0V	-40°C to 85°C	-	-	6	
		V_{CC} =4.5V, I_{O} =-30mA, V_{IN} =2.4V		-	-	8	
		V_{CC} =4.5V, I_{O} =-30mA, V_{IN} =4.5V		-	-	11	
		$V_{CC}=3.0V, I_{O}=24mA, V_{IN}=0V$	25°C	-	5	8	
		V_{CC} =3.0V, I_{O} =-24mA, V_{IN} =3.0V	25 C	-	10	15	
R _{ON}	ON Resistance ⁽¹⁾	$V_{CC}=3.0V, I_{O}=24mA, V_{IN}=0V$	-40°C to 85°C	-	-	8	Ω
KON	On Resistance	$V_{CC}=3.0V, I_{O}=-24mA, V_{IN}=3.0V$	-40 C 10 85 C	-	-	15	52
		$V_{CC}=2.3V, I_{O}=8mA, V_{IN}=0V$	25°C	-	6	9	
		$V_{CC}=2.3V, I_{O}=-8mA, V_{IN}=2.3V$	25 C	-	13	20	
		$V_{CC}=2.3V, I_{O}=8mA, V_{IN}=0V$	-40°C to 85°C	-	-	9	
		$V_{CC}=2.3V, I_{O}=-8mA, V_{IN}=2.3V$	-40 C 10 85 C	-	-	20	
		V_{CC} =1.65V, I_{O} =4mA, V_{IN} =0V	25°C	-	8	12	
		V_{CC} =1.65V, I_{O} =-4mA, V_{IN} =1.65V	25 C	-	20	30	
		V_{CC} =1.65V, I_{O} =4mA, V_{IN} =0V	-40°C to 85°C	-	-	12	
		V_{CC} =1.65V, I_{O} =-4mA, V_{IN} =1.65V	-40 C 10 85 C	-	-	25	
	ON Resistance Match Between Channels ^(1,2,3)	V _{CC} =4.5V, I _A =-30mA, V _{IN} =3.15V	25°C	-	0.15	-	Ω
٨D		$V_{CC}=3.0V, I_{A}=-24mA, V_{IN}=2.1V$		-	0.2	-	
ΔR_{ON}		V _{CC} =2.3V, I _A =-8mA, V _{IN} =1.6V		-	0.3	-	
		$V_{CC}=1.65V, I_{A}=-4mA, V_{IN}=0V$		-	0.5	-	
	ON Resistance Flatness ^(1,2,4)	$V_{CC}=5.0V, I_{A}=-30mA,$	25°C		(Ω
		$0 \le V_{IN} \le V_{CC}$		-	6	-	
R _{ONF}		$V_{CC}=3.3V, I_{A}=-24mA, 0 \le V_{IN} \le V_{CC}$		-	12	-	
		$V_{CC}=2.5V, I_{A}=-8mA, 0 \le V_{IN} \le V_{CC}$		-	22	-	
		V_{CC} =1.8V, I_A =-4mA, 0 $\leq V_{IN} \leq V_{CC}$		-	90	-	
		V _{CC} =1.65V		1	-	-	
	T TT' - 1. X7 - 1	$V_{CC} = 2.3 V$		1.2	-	-	
V _{IH}	Input High Voltage	$V_{CC} = 3V$	-40°C to 85°C	1.3	-	-	V
	(Logic High Level)	$V_{CC} = 4.2V$		1.5	-	-	
		$V_{CC} = 5.5 V$		1.8	-	-	1
		V _{CC} =1.65V		-	-	0.4	v
	T (T T 1)	$V_{CC} = 2.3 V$		-	-	0.6	
V _{IL}	Input Low Voltage (Logic Low Level)	$V_{CC} = 3V$	-40°C to 85°C	-	-	0.8	
· IL		$V_{CC} = 4.2V$		-	-	1	
		$V_{CC} = 5.5 V$		-	-	1.2	
T	Input Leakage		25°C	-	-	±0.1	
I _{LKC}	Current	$0 \le V_{IN} \le 5.5V$, $V_{CC} = 0V$ to $5.5V$	-40°C to 85°C	-	-	±1.0	μA
т	OFF State Leakage		25°C	-	-	±0.1	μA
I _{OFF}	Current	$0 \le V_{IN} \le 5.5 V$, $V_{CC} = 1.65 V$ to $5.5 V$	-40°C to 85°C	-	-	±10	
T	Quiescent Supply	All channels ON or OFF, $V_{IN} = V_{CC}$	25°C	-	-	1	<u> </u>
I _{CC}	Current	or GND, $I_{OUT}=0$, $V_{CC}=5.5V$	-40°C to 85°C	-		5	μA

DC Electrical Characteristics ($T_A = -40$ °C to 85 °C, unless otherwise noted.)

Notes:

1. Measured by voltage drop between A and B pins at the indicated current through the device. ON resistance is determined by the lower of the voltages on two ports (A or B).

2. Parameter is characterized but not tested in production.

3. $DR_{ON} = R_{ON} \max - R_{ON} \min$ measured at identical V_{CC}, temperature and voltage levels.

4. Flatness is defined as difference between maximum and minimum value of ON resistance over the specified range of conditions. Guaranteed by design.





Capacitance⁽¹⁾($T_A = 25^{\circ}C$, unless otherwise noted.)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
C _{IN}	Control Input		-	2.5	-	
C _{IO-B}	For B Port, Switch OFF	(1)	-	5.0	-	
C _{IOA-ON}	For A Port, Switch ON	$V_{CC} = 5.0V, f = 1 MHz^{(1)}$	-	15.0	-	pF

Notes:

1. Capacitance is characterized but not tested in production

Switch and AC Characteristics⁽¹⁾

Parameter	Description	Test Conditions	Supply Voltage	Temperature (T _A : ℃)	Min	Тур	Max	Units
			$V_{CC} = 1.65V$ to $1.95V$		-	-	3.5	
t _{PLH}	Propagation	See test circuit diagrams 1 and 2. V_I Open	$V_{\rm CC}$ =2.3V to 2.7V	−40 to 85°C	-	-	1.1	
t _{PHL}	Delay: A to Bn		$V_{\rm CC} = 3.0 \text{V} \text{ to } 3.6 \text{V}$		-	-	0.9	
			$V_{\rm CC}$ =4.5V to 5.5V		-	-	0.6	
			$V_{\rm CC} = 1.65 \text{V}$ to 1.95V		6	-	13	1
t _{. PZL}	Output Enable	See test circuit diagrams 1&2.	$V_{\rm CC}$ =2.3V to 2.7V	40 / 0500	3.5	-	8.0	
t _{PZH}	Turn ON Time: A to Bn	$V_{I} = 2V_{CC}$ for t_{PZL} ,	$V_{\rm CC} = 3.0 \text{V} \text{ to } 3.6 \text{V}$	-40 to 85°C	2.5	-	6.9	ns
		$V_I = 0V$ for t_{PZH}	$V_{\rm CC}$ =4.5V to 5.5V		1.7	-	5.2	
		See test circuit diagrams 1	$V_{\rm CC} = 1.65 \text{V}$ to 1.95V		3	-	13	
t _{PLZ}	Output Disable Turn OFF Time:A to Bn	_	$V_{\rm CC}$ =2.3V to 2.7V	40 to 85℃	2	-	9	
			$V_{\rm CC} = 3.0 \text{V} \text{ to } 3.6 \text{V}$		1.5	-	7.0	
			$V_{\rm CC}$ =4.5V to 5.5V		0.8	-	4.5	
t	Break Before	See test circuit diagram 3.	$V_{\rm CC}$ =1.65V to 1.95V	-40 to 85℃	-	3.7	-	
			$V_{\rm CC}$ =2.3V to 2.7V		-	2.5	-	
t _{BM}	Make Time		$V_{\rm CC}$ =3.0V to 3.6V		-	2.5	-	
			V_{CC} =4.5V to 5.5V		-	1.6	-	
Q	Charge	$C_{\rm L} = 0.1 \text{nF}, V_{\rm GEN} = 0 \text{V},$	$V_{CC} = 5.0V$	25℃	-	5	-	- nC
Q	Injection	R _{GEN} =0Ω. See test circuit 4.	$V_{CC} = 3.3V$	25 C	-	- 4 -		pC
OIRR	Off Isolation	$R_L = 50\Omega$, $V_{GEN} = 0V$, $R_{GEN} = 0\Omega$, $f = 10MHz$. See test circuit 5	$V_{CC} = 1.65 V$ to 5.5 V	25℃	-	-63	-	dB
X _{TALK}	Crosstalk Isolation	See test circuit 6 ⁽⁴⁾	$V_{\rm CC}$ =1.65V to 5.5V	25°C	-	-64	-	
f3dB	-3dB Bandwidth	See test circuit 9	$V_{\rm CC}$ =1.65V to 5.5V	25℃	-	350	-	MHz
T_{HD}	Total Harmonic Distortion	R_L =600 Ω , V_{IN} =0.5Vpp, f=20Hz to 20kHz	$V_{CC} = 1.65 V$ to 5.5 V	25℃	-	0.012	-	%

1. Guaranteed by design.

2. The device contributes no other propagation delay other than the RC delay of the switch ON resistance and the 50pF load capacitance, when driven by an ideal voltage source with zero output impedance.

3. Off Isolation = 20 Log₁₀ [V_{Bn}/V_A] and is measured in dB.

4. Crosstalk Isolation = 20 Log_{10} [V_{B1}/V_{B0}] and is measured in dB.





Test Circuits and Timing Diagrams



Note: Input driven by 500hm source terminated in 5000hm Note: C_L Includes load and stray capacitance Note: Input PRR=1.0MHz, t_W =500nS





Figure 2. AC Waveforms



Figure 3. Break Before Make Interval Timing



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Figure 4. Charge Injection Test



Figure 5. Off Isolation



Figure 6. Crosstalk



Figure 7. Channel Off Capacitance



Figure 8. Channel On Capacitance



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Figure 9. Bandwidth



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Mechanical Information: 6-UDFN (ZU)



Marking Description



Shortened Part No





6-SC70 (C6)



16-0078

For latest package info.

please check: http://www.diodes.com/design/support/packaging/pericom-packaging/packaging-mechanicals-and-thermal-characteristics/

Ordering Information

Part Number	Package Code	Package	Top Marking
PI5A3157BZUEX	ZU	6-Pin, 1x1 (UDFN)	b
PI5A3157BC6EX	C6	6-Pin, SOT363 (SC70)	kD

Notes:

• Thermal characteristics can be found on the company web site at www.diodes.com/design/support/packaging/

• E = Pb-free and Green

• X suffix = Tape/Reel



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